

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/028,825	YAMASAKI ET AL.	
Examiner	Art Unit	
Mai T. Tran	2121	

SEARCHED						
Class	Subclass	Date	Examiner			
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Please see attached documents	2/1/2005	mtt		
		 		
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